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April 17, 2003

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Applicant	:	Kikuchi, et al.)	Group Art Unit 2831
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Appl. No.	:	09/881,256)	I hereby certify that this correspondence and all
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March 10, 2003

(Date)

Thomas R. Arbo, Reg. No. 40,490

AMENDMENT AFTER FINAL OFFICE ACTION

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Dear Sir:

In response to the Office Action mailed October 10, 2002, please amend the above identified application as shown in the accompanying pages. Applicant, by this paper, amends Claims 1 and cancels Claims 2-13 without prejudice. Thus, Claims 1 and 14 remain pending in the application and are presented for reconsideration.

IN THE DRAWINGS

Please amend Figures 1 and 2 as shown in the attached redline drawing. In FIG. 1 the reference designator "2" identifying the first (inner) aluminum strands has been amended to "2A". The reference designator "2" identifying the second (outer) aluminum strands has been amended to "2B". In FIG. 2 the reference designator "2" has been amended to indicate "2B". The reference designators in the drawings, as amended, conform with the description provided in the specification at page 5 line 12 through page 6 line 5. No new matter has been added by this amendment.

Applicant will file formal drawings upon approval of the drawing correction.